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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	180MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I <sup>2</sup> C, IrDA, LINbus, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I <sup>2</sup> S, LCD, POR, PWM, WDT
Number of I/O	82
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	256K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 16x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f437vit6tr">https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f437vit6tr</a>

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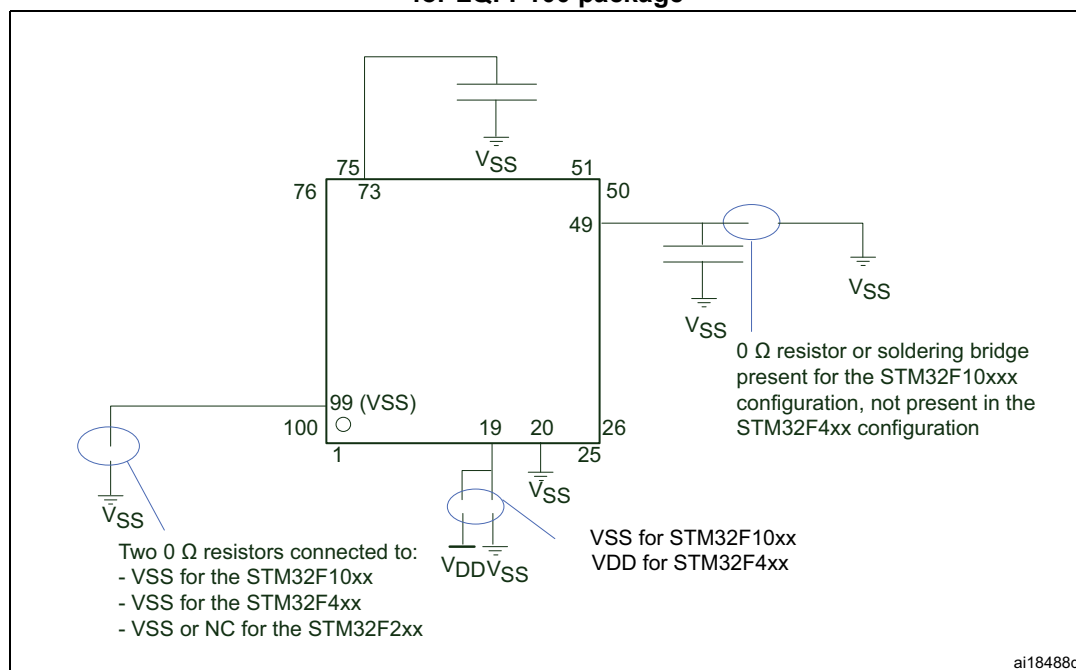
## 2.1 Full compatibility throughout the family

The STM32F437xx and STM32F439xx devices are part of the STM32F4 family. They are fully pin-to-pin, software and feature compatible with the STM32F2xx devices, allowing the user to try different memory densities, peripherals, and performances (FPU, higher frequency) for a greater degree of freedom during the development cycle.

The STM32F437xx and STM32F439xx devices maintain a close compatibility with the whole STM32F10xx family. All functional pins are pin-to-pin compatible. The STM32F437xx and STM32F439xx, however, are not drop-in replacements for the STM32F10xx devices: the two families do not have the same power scheme, and so their power pins are different. Nonetheless, transition from the STM32F10xx to the STM32F4xx family remains simple as only a few pins are impacted.

[Figure 1](#), [Figure 2](#), and [Figure 3](#), give compatible board designs between the STM32F4xx, STM32F2xx, and STM32F10xx families.

**Figure 1. Compatible board design STM32F10xx/STM32F2xx/STM32F4xx for LQFP100 package**



detected, the system automatically switches back to the internal RC oscillator and a software interrupt is generated (if enabled). This clock source is input to a PLL thus allowing to increase the frequency up to 180 MHz. Similarly, full interrupt management of the PLL clock entry is available when necessary (for example if an indirectly used external oscillator fails).

Several prescalers allow the configuration of the two AHB buses, the high-speed APB (APB2) and the low-speed APB (APB1) domains. The maximum frequency of the two AHB buses is 180 MHz while the maximum frequency of the high-speed APB domains is 90 MHz. The maximum allowed frequency of the low-speed APB domain is 45 MHz.

The devices embed a dedicated PLL (PLL12S) and PLLSAI which allows to achieve audio class performance. In this case, the I<sup>2</sup>S master clock can generate all standard sampling frequencies from 8 kHz to 192 kHz.

### 3.15 Boot modes

At startup, boot pins are used to select one out of three boot options:

- Boot from user Flash
- Boot from system memory
- Boot from embedded SRAM

The boot loader is located in system memory. It is used to reprogram the Flash memory through a serial interface. Refer to application note AN2606 for details.

### 3.16 Power supply schemes

- $V_{DD} = 1.7$  to  $3.6$  V: external power supply for I/Os and the internal regulator (when enabled), provided externally through  $V_{DD}$  pins.
- $V_{SSA}$ ,  $V_{DDA} = 1.7$  to  $3.6$  V: external analog power supplies for ADC, DAC, Reset blocks, RCs and PLL.  $V_{DDA}$  and  $V_{SSA}$  must be connected to  $V_{DD}$  and  $V_{SS}$ , respectively.
- $V_{BAT} = 1.65$  to  $3.6$  V: power supply for RTC, external clock 32 kHz oscillator and backup registers (through power switch) when  $V_{DD}$  is not present.

*Note:*  $V_{DD}/V_{DDA}$  minimum value of 1.7 V is obtained with the use of an external power supply supervisor (refer to [Section 3.17.2: Internal reset OFF](#)). Refer to [Table 3: Voltage regulator configuration mode versus device operating mode](#) to identify the packages supporting this option.

### 3.17 Power supply supervisor

#### 3.17.1 Internal reset ON

On packages embedding the PDR\_ON pin, the power supply supervisor is enabled by holding PDR\_ON high. On the other package, the power supply supervisor is always enabled.

The device has an integrated power-on reset (POR)/ power-down reset (PDR) circuitry coupled with a Brownout reset (BOR) circuitry. At power-on, POR/PDR is always active and ensures proper operation starting from 1.8 V. After the 1.8 V POR threshold level is

### 3.22.1 Advanced-control timers (TIM1, TIM8)

The advanced-control timers (TIM1, TIM8) can be seen as three-phase PWM generators multiplexed on 6 channels. They have complementary PWM outputs with programmable inserted dead times. They can also be considered as complete general-purpose timers. Their 4 independent channels can be used for:

- Input capture
- Output compare
- PWM generation (edge- or center-aligned modes)
- One-pulse mode output

If configured as standard 16-bit timers, they have the same features as the general-purpose TIMx timers. If configured as 16-bit PWM generators, they have full modulation capability (0-100%).

The advanced-control timer can work together with the TIMx timers via the Timer Link feature for synchronization or event chaining.

TIM1 and TIM8 support independent DMA request generation.

### 3.22.2 General-purpose timers (TIMx)

There are ten synchronizable general-purpose timers embedded in the STM32F43x devices (see [Table 6](#) for differences).

- **TIM2, TIM3, TIM4, TIM5**

The STM32F43x include 4 full-featured general-purpose timers: TIM2, TIM5, TIM3, and TIM4. The TIM2 and TIM5 timers are based on a 32-bit auto-reload up/downcounter and a 16-bit prescaler. The TIM3 and TIM4 timers are based on a 16-bit auto-reload up/downcounter and a 16-bit prescaler. They all feature 4 independent channels for input capture/output compare, PWM or one-pulse mode output. This gives up to 16 input capture/output compare/PWMs on the largest packages.

The TIM2, TIM3, TIM4, TIM5 general-purpose timers can work together, or with the other general-purpose timers and the advanced-control timers TIM1 and TIM8 via the Timer Link feature for synchronization or event chaining.

Any of these general-purpose timers can be used to generate PWM outputs.

TIM2, TIM3, TIM4, TIM5 all have independent DMA request generation. They are capable of handling quadrature (incremental) encoder signals and the digital outputs from 1 to 4 hall-effect sensors.

- **TIM9, TIM10, TIM11, TIM12, TIM13, and TIM14**

These timers are based on a 16-bit auto-reload upcounter and a 16-bit prescaler. TIM10, TIM11, TIM13, and TIM14 feature one independent channel, whereas TIM9 and TIM12 have two independent channels for input capture/output compare, PWM or one-pulse mode output. They can be synchronized with the TIM2, TIM3, TIM4, TIM5 full-featured general-purpose timers. They can also be used as simple time bases.

### 3.22.3 Basic timers TIM6 and TIM7

These timers are mainly used for DAC trigger and waveform generation. They can also be used as a generic 16-bit time base.

TIM6 and TIM7 support independent DMA request generation.

### 3.26 Inter-integrated sound (I<sup>2</sup>S)

Two standard I<sup>2</sup>S interfaces (multiplexed with SPI2 and SPI3) are available. They can be operated in master or slave mode, in full duplex and simplex communication modes, and can be configured to operate with a 16-/32-bit resolution as an input or output channel. Audio sampling frequencies from 8 kHz up to 192 kHz are supported. When either or both of the I<sup>2</sup>S interfaces is/are configured in master mode, the master clock can be output to the external DAC/CODEC at 256 times the sampling frequency.

All I2Sx can be served by the DMA controller.

*Note:* For I2S2 full-duplex mode, I2S2\_CK and I2S2\_WS signals can be used only on GPIO Port B and GPIO Port D.

### 3.27 Serial Audio interface (SAI1)

The serial audio interface (SAI1) is based on two independent audio sub-blocks which can operate as transmitter or receiver with their FIFO. Many audio protocols are supported by each block: I2S standards, LSB or MSB-justified, PCM/DSP, TDM, AC'97 and SPDIF output, supporting audio sampling frequencies from 8 kHz up to 192 kHz. Both sub-blocks can be configured in master or in slave mode.

In master mode, the master clock can be output to the external DAC/CODEC at 256 times of the sampling frequency.

The two sub-blocks can be configured in synchronous mode when full-duplex mode is required.

SAI1 can be served by the DMA controller.

### 3.28 Audio PLL (PLLI2S)

The devices feature an additional dedicated PLL for audio I<sup>2</sup>S and SAI applications. It allows to achieve error-free I<sup>2</sup>S sampling clock accuracy without compromising on the CPU performance, while using USB peripherals.

The PLLI2S configuration can be modified to manage an I<sup>2</sup>S/SAI sample rate change without disabling the main PLL (PLL) used for CPU, USB and Ethernet interfaces.

The audio PLL can be programmed with very low error to obtain sampling rates ranging from 8 KHz to 192 KHz.

In addition to the audio PLL, a master clock input pin can be used to synchronize the I<sup>2</sup>S/SAI flow with an external PLL (or Codec output).

### 3.29 Audio and LCD PLL(PLLSAI)

An additional PLL dedicated to audio and LCD-TFT is used for SAI1 peripheral in case the PLLI2S is programmed to achieve another audio sampling frequency (49.152 MHz or 11.2896 MHz) and the audio application requires both sampling frequencies simultaneously.

The PLLSAI is also used to generate the LCD-TFT clock.

Table 10. STM32F437xx and STM32F439xx pin and ball definitions (continued)

Pin number								Pin name (function after reset) <sup>(1)</sup>	Pin type	I / O structure	Notes	Alternate functions	Additional functions
LQFP100	LQFP144	UFBGA169	UFBGA176	LQFP176	WLCSP143	LQFP208	TFBGA216						
49	71	N9	M10	81	N2	92	L11	V <sub>CAP_1</sub>	S	-	-	-	-
-	-	-	-	-	H2	93	K9	V <sub>SS</sub>	S	-	-	-	-
50	72	F8	N10	82	J6	94	L10	V <sub>DD</sub>	S	-	-	-	-
-	-	-	-	-	-	95	M14	PJ5	I/O	-	-	LCD_R6, EVENTOUT	-
-	-	N10	M11	83	-	96	P13	PH6	I/O	FT	-	I2C2_SMBA, SPI5_SCK, TIM12_CH1, ETH_MII_RXD2, FMC_SDNE1, DCMI_D8, EVENTOUT	-
-	-	M10	N12	84	-	97	N13	PH7	I/O	FT	-	I2C3_SCL, SPI5_MISO, ETH_MII_RXD3, FMC_SCKE1, DCMI_D9, EVENTOUT	-
-	-	L10	M12	85	-	98	P14	PH8	I/O	FT	-	I2C3_SDA, FMC_D16, DCMI_HSYNC, LCD_R2, EVENTOUT	-
-	-	K10	M13	86	-	99	N14	PH9	I/O	FT	-	I2C3_SMBA, TIM12_CH2, FMC_D17, DCMI_D0, LCD_R3, EVENTOUT	-
-	-	N11	L13	87	-	100	P15	PH10	I/O	FT	-	TIM5_CH1, FMC_D18, DCMI_D1, LCD_R4, EVENTOUT	-
-	-	M11	L12	88	-	101	N15	PH11	I/O	FT	-	TIM5_CH2, FMC_D19, DCMI_D2, LCD_R5, EVENTOUT	-
-	-	L11	K12	89	-	102	M15	PH12	I/O	FT	-	TIM5_CH3, FMC_D20, DCMI_D3, LCD_R6, EVENTOUT	-
-	-	E7	H12	90	-	-	K10	V <sub>SS</sub>	S	-	-	-	-
-	-	H8	J12	91	-	103	K11	V <sub>DD</sub>	S	-	-	-	-



Table 10. STM32F437xx and STM32F439xx pin and ball definitions (continued)

Pin number								Pin name (function after reset) <sup>(1)</sup>	Pin type	I / O structure	Notes	Alternate functions	Additional functions
LQFP100	LQFP144	UFBGA169	UFBGA176	LQFP176	WLCSP143	LQFP208	TFBGA216						
-	91	G11	J15	110	G4	133	J15	PG6	I/O	FT	-	FMC_INT2, DCMI_D12, LCD_R7, EVENTOUT	-
-	92	G12	J14	111	H1	134	J14	PG7	I/O	FT	-	USART6_CK, FMC_INT3, DCMI_D13, LCD_CLK, EVENTOUT	-
-	93	F13	H14	112	G2	135	H14	PG8	I/O	FT	-	SPI6_NSS, USART6_RTS, ETH_PPS_OUT, FMC_SDCLK, EVENTOUT	-
-	94	J7	G12	113	D2	136	G10	V <sub>SS</sub>	S		-	-	-
-	95	E6	H13	114	G1	137	G11	V <sub>DD</sub>	S		-	-	-
63	96	F9	H15	115	F2	138	H15	PC6	I/O	FT	-	TIM3_CH1, TIM8_CH1, I2S2_MCK, USART6_TX, SDIO_D6, DCMI_D0, LCD_HSYNC, EVENTOUT	-
64	97	F10	G15	116	F3	139	G15	PC7	I/O	FT	-	TIM3_CH2, TIM8_CH2, I2S3_MCK, USART6_RX, SDIO_D7, DCMI_D1, LCD_G6, EVENTOUT	-
65	98	F11	G14	117	E4	140	G14	PC8	I/O	FT	-	TIM3_CH3, TIM8_CH3, USART6_CK, SDIO_D0, DCMI_D2, EVENTOUT	-
66	99	F12	F14	118	E3	141	F14	PC9	I/O	FT	-	MCO2, TIM3_CH4, TIM8_CH4, I2C3_SDA, I2S_CKIN, SDIO_D1, DCMI_D3, EVENTOUT	-
67	100	E13	F15	119	F1	142	F15	PA8	I/O	FT	-	MCO1, TIM1_CH1, I2C3_SCL, USART1_CK, OTG_FS_SOF, LCD_R6, EVENTOUT	-



Table 12. STM32F437xx and STM32F439xx alternate function mapping (continued)

Port		AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
		SYS	TIM1/2	TIM3/4/5	TIM8/9/ 10/11	I2C1/ 2/3	SPI1/2/ 3/4/5/6	SPI2/3/ SAI1	SPI3/ USART1/ 2/3	USART6/ UART4/5/7 /8	CAN1/2/ TIM12/13/14 /LCD	OTG2_HS /OTG1_ FS	ETH	FMC/SDIO /OTG2_FS	DCMI	LCD	SYS
Port G	PG9	-	-	-	-	-	-	-	-	USART6_ RX	-	-	-	FMC_NE2/ FMC_ NCE3	DCMI_ VSYNC (1)	-	EVEN TOUT
	PG10	-	-	-	-	-	-	-	-	-	LCD_G3	-	-	FMC_ NCE4_1/ FMC_NE3	DCMI_ D2	LCD_B2	EVEN TOUT
	PG11	-	-	-	-	-	-	-	-	-	-	-	ETH_MII_ TX_EN/ ETH_RMII_ TX_EN	FMC_ NCE4_2	DCMI_ D3	LCD_B3	EVEN TOUT
	PG12	-	-	-	-	-	SPI6_ MISO	-	-	USART6_ RTS	LCD_B4	-	-	FMC_NE4	-	LCD_B1	EVEN TOUT
	PG13	-	-	-	-	-	SPI6_ SCK	-	-	USART6_ CTS	-	-	ETH_MII_ TXD0/ ETH_RMII_ TXD0	FMC_A24	-	-	EVEN TOUT
	PG14	-	-	-	-	-	SPI6_ MOSI	-	-	USART6_ TX	-	-	ETH_MII_ TXD1/ ETH_RMII_ TXD1	FMC_A25	-	-	EVEN TOUT
	PG15	-	-	-	-	-	-	-	-	USART6_ CTS	-	-	-	FMC_ SDNCAS	DCMI_ D13	-	EVEN TOUT
Port H	PH0	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	EVEN TOUT
	PH1	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	EVEN TOUT
	PH2	-	-	-	-	-	-	-	-	-	-	-	ETH_MII_ CRS	FMC_ SDCKE0	-	LCD_R0	EVEN TOUT
	PH3	-	-	-	-	-	-	-	-	-	-	-	ETH_MII_ COL	FMC_SDN_ E0	-	LCD_R1	EVEN TOUT
	PH4	-	-	-	-	I2C2_ SCL	-	-	-	-	-	OTG_HS_ ULPI_NXT	-	-	-	-	EVEN TOUT
	PH5	-	-	-	-	I2C2_ SDA	SPI5_N SS	-	-	-	-	-	-	FMC_SDN_ WE	-	-	EVEN TOUT
	PH6	-	-	-	-	I2C2_ SMBA	SPI5_ SCK	-	-	-	TIM12_CH1	-	-	FMC_ SDNE1	DCMI_ D8	-	-

Table 15. Current characteristics

Symbol	Ratings	Max.	Unit
$\Sigma I_{VDD}$	Total current into sum of all $V_{DD\_x}$ power lines (source) <sup>(1)</sup>	270	mA
$\Sigma I_{VSS}$	Total current out of sum of all $V_{SS\_x}$ ground lines (sink) <sup>(1)</sup>	– 270	
$I_{VDD}$	Maximum current into each $V_{DD\_x}$ power line (source) <sup>(1)</sup>	100	
$I_{VSS}$	Maximum current out of each $V_{SS\_x}$ ground line (sink) <sup>(1)</sup>	– 100	
$I_{IO}$	Output current sunk by any I/O and control pin	25	
	Output current sourced by any I/Os and control pin	– 25	
$\Sigma I_{IO}$	Total output current sunk by sum of all I/O and control pins <sup>(2)</sup>	120	
	Total output current sourced by sum of all I/Os and control pins <sup>(2)</sup>	– 120	
$I_{INJ(PIN)}$ <sup>(3)</sup>	Injected current on FT pins <sup>(4)</sup>	– 5/+0	
	Injected current on NRST and BOOT0 pins <sup>(4)</sup>		
	Injected current on TTa pins <sup>(5)</sup>	±5	
$\Sigma I_{INJ(PIN)}$ <sup>(5)</sup>	Total injected current (sum of all I/O and control pins) <sup>(6)</sup>	±25	

1. All main power ( $V_{DD}$ ,  $V_{DDA}$ ) and ground ( $V_{SS}$ ,  $V_{SSA}$ ) pins must always be connected to the external power supply, in the permitted range.
2. This current consumption must be correctly distributed over all I/Os and control pins. The total output current must not be sunk/sourced between two consecutive power supply pins referring to high pin count LQFP packages.
3. Negative injection disturbs the analog performance of the device. See note in [Section 6.3.21: 12-bit ADC characteristics](#).
4. Positive injection is not possible on these I/Os and does not occur for input voltages lower than the specified maximum value.
5. A positive injection is induced by  $V_{IN} > V_{DDA}$  while a negative injection is induced by  $V_{IN} < V_{SS}$ .  $I_{INJ(PIN)}$  must never be exceeded. Refer to [Table 14](#) for the values of the maximum allowed input voltage.
6. When several inputs are submitted to a current injection, the maximum  $\Sigma I_{INJ(PIN)}$  is the absolute sum of the positive and negative injected currents (instantaneous values).

Table 16. Thermal characteristics

Symbol	Ratings	Value	Unit
$T_{STG}$	Storage temperature range	– 65 to +150	°C
$T_J$	Maximum junction temperature	125	°C

**Additional current consumption**

The MCU is placed under the following conditions:

- All I/O pins are configured in analog mode.
- The Flash memory access time is adjusted to f<sub>HCLK</sub> frequency.
- The voltage scaling is adjusted to f<sub>HCLK</sub> frequency as follows:
  - Scale 3 for f<sub>HCLK</sub> ≤ 120 MHz,
  - Scale 2 for 120 MHz < f<sub>HCLK</sub> ≤ 144 MHz
  - Scale 1 for 144 MHz < f<sub>HCLK</sub> ≤ 180 MHz. The over-drive is only ON at 180 MHz.
- The system clock is HCLK, f<sub>PCLK1</sub> = f<sub>HCLK</sub>/4, and f<sub>PCLK2</sub> = f<sub>HCLK</sub>/2.
- HSE crystal clock frequency is 25 MHz.
- When the regulator is OFF, V12 is provided externally as described in [Table 17: General operating conditions](#)
- T<sub>A</sub> = 25 °C .

**Table 30. Typical current consumption in Run mode, code with data processing running from Flash memory or RAM, regulator ON (ART accelerator enabled except prefetch), V<sub>DD</sub>=1.7 V<sup>(1)</sup>**

Symbol	Parameter	Conditions	f <sub>HCLK</sub> (MHz)	Typ	Unit
I <sub>DD</sub>	Supply current in RUN mode from V <sub>DD</sub> supply	All Peripheral enabled	168	88.2	mA
			150	74.3	
			144	71.3	
			120	52.9	
			90	42.6	
			60	28.6	
			30	15.7	
			25	12.3	
		All Peripheral disabled	168	40.6	
			150	30.6	
			144	32.6	
			120	24.7	
			90	19.7	
			60	13.6	
			30	7.7	
			25	6.7	

1. When peripherals are enabled, the power consumption corresponding to the analog part of the peripherals (such as ADC, or DAC) is not included.

Table 58. I/O AC characteristics<sup>(1)(2)</sup> (continued)

OSPEEDRy [1:0] bit value <sup>(1)</sup>	Symbol	Parameter	Conditions	Min	Typ	Max	Unit
11	$f_{\max(\text{IO})\text{out}}$	Maximum frequency <sup>(3)</sup>	$C_L = 30 \text{ pF}, V_{DD} \geq 2.7 \text{ V}$	-	-	100 <sup>(4)</sup>	MHz
			$C_L = 30 \text{ pF}, V_{DD} \geq 1.8 \text{ V}$	-	-	50	
			$C_L = 30 \text{ pF}, V_{DD} \geq 1.7 \text{ V}$	-	-	42.5	
			$C_L = 10 \text{ pF}, V_{DD} \geq 2.7 \text{ V}$	-	-	180 <sup>(4)</sup>	
			$C_L = 10 \text{ pF}, V_{DD} \geq 1.8 \text{ V}$	-	-	100	
			$C_L = 10 \text{ pF}, V_{DD} \geq 1.7 \text{ V}$	-	-	72.5	
	$t_{f(\text{IO})\text{out}}/$ $t_{r(\text{IO})\text{out}}$	Output high to low level fall time and output low to high level rise time	$C_L = 30 \text{ pF}, V_{DD} \geq 2.7 \text{ V}$	-	-	4	ns
			$C_L = 30 \text{ pF}, V_{DD} \geq 1.8 \text{ V}$	-	-	6	
			$C_L = 30 \text{ pF}, V_{DD} \geq 1.7 \text{ V}$	-	-	7	
			$C_L = 10 \text{ pF}, V_{DD} \geq 2.7 \text{ V}$	-	-	2.5	
			$C_L = 10 \text{ pF}, V_{DD} \geq 1.8 \text{ V}$	-	-	3.5	
			$C_L = 10 \text{ pF}, V_{DD} \geq 1.7 \text{ V}$	-	-	4	
-	$t_{\text{EXTI}pw}$	Pulse width of external signals detected by the EXTI controller	-	10	-	-	ns

1. Guaranteed by design.
2. The I/O speed is configured using the OSPEEDRy[1:0] bits. Refer to the STM32F4xx reference manual for a description of the GPIOx\_SPEEDR GPIO port output speed register.
3. The maximum frequency is defined in [Figure 36](#).
4. For maximum frequencies above 50 MHz and  $V_{DD} > 2.4 \text{ V}$ , the compensation cell should be used.

Figure 36. I/O AC characteristics definition

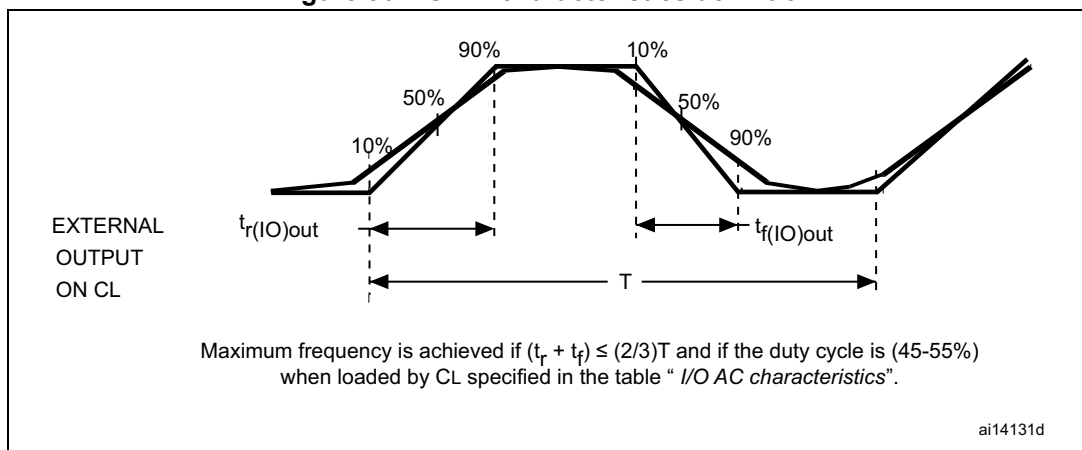
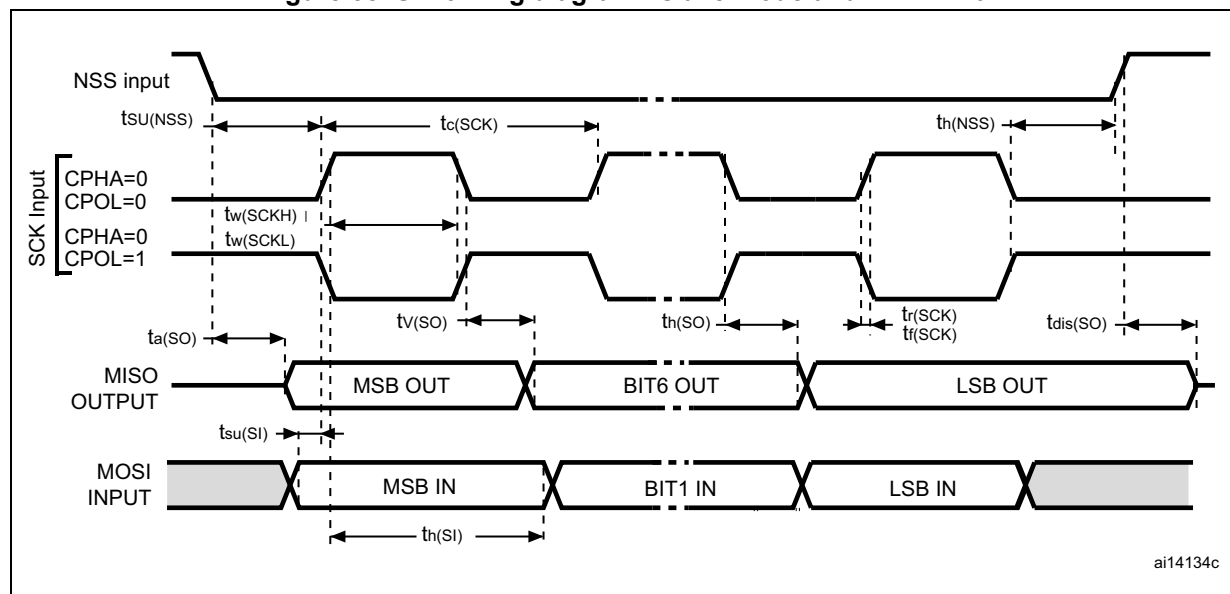
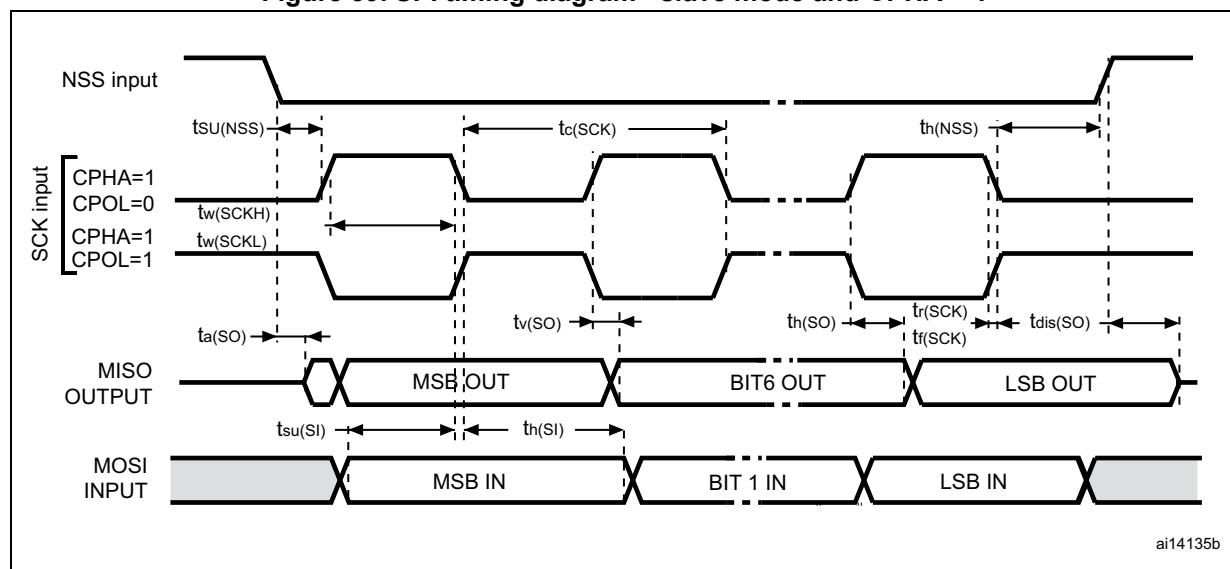


Figure 38. SPI timing diagram - slave mode and CPHA = 0



ai14134c

Figure 39. SPI timing diagram - slave mode and CPHA = 1



ai14135b

Table 70. Dynamic characteristics: USB ULPI<sup>(1)</sup>

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t <sub>SC</sub>	Control in (ULPI_DIR, ULPI_NXT) setup time		2	-	-	ns
t <sub>HC</sub>	Control in (ULPI_DIR, ULPI_NXT) hold time		0.5	-	-	
t <sub>SD</sub>	Data in setup time		1.5	-	-	
t <sub>HD</sub>	Data in hold time		2	-	-	
t <sub>DC</sub> /t <sub>DD</sub>	Data/control output delay	2.7 V < V <sub>DD</sub> < 3.6 V, C <sub>L</sub> = 15 pF and OSPEEDRy[1:0] = 11	-	9	9.5	
		2.7 V < V <sub>DD</sub> < 3.6 V, C <sub>L</sub> = 20 pF and OSPEEDRy[1:0] = 10	-	12	15	
		1.7 V < V <sub>DD</sub> < 3.6 V, C <sub>L</sub> = 15 pF and OSPEEDRy[1:0] = 11	-			

1. Guaranteed by characterization results.

## 6.3.25 DAC electrical characteristics

Table 85. DAC characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit	Comments
V <sub>DDA</sub>	Analog supply voltage	-		1.7 <sup>(1)</sup>	-	3.6	V	-
V <sub>REF+</sub>	Reference supply voltage	-		1.7 <sup>(1)</sup>	-	3.6	V	V <sub>REF+</sub> ≤ V <sub>DDA</sub>
V <sub>SSA</sub>	Ground	-		0	-	0	V	-
R <sub>LOAD</sub> <sup>(2)</sup>	Resistive load	DAC output buffer ON	R <sub>LOAD</sub> connected to V <sub>SSA</sub>	5	-	-	kΩ	-
			R <sub>LOAD</sub> connected to V <sub>DDA</sub>	25				-
R <sub>O</sub> <sup>(2)</sup>	Impedance output with buffer OFF	-		-	-	15	kΩ	When the buffer is OFF, the Minimum resistive load between DAC_OUT and V <sub>SS</sub> to have a 1% accuracy is 1.5 MΩ
C <sub>LOAD</sub> <sup>(2)</sup>	Capacitive load	-		-	-	50	pF	Maximum capacitive load at DAC_OUT pin (when the buffer is ON).
DAC_O <sub>UT</sub> min <sup>(2)</sup>	Lower DAC_OUT voltage with buffer ON	-		0.2	-	-	V	It gives the maximum output excursion of the DAC. It corresponds to 12-bit input code (0x0E0) to (0xF1C) at V <sub>REF+</sub> = 3.6 V and (0x1C7) to (0xE38) at V <sub>REF+</sub> = 1.7 V
DAC_O <sub>UT</sub> max <sup>(2)</sup>	Higher DAC_OUT voltage with buffer ON	-		-	-	V <sub>DDA</sub> – 0.2	V	
DAC_O <sub>UT</sub> min <sup>(2)</sup>	Lower DAC_OUT voltage with buffer OFF	-		-	0.5	-	mV	It gives the maximum output excursion of the DAC.
DAC_O <sub>UT</sub> max <sup>(2)</sup>	Higher DAC_OUT voltage with buffer OFF	-		-	-	V <sub>REF+</sub> – 1LSB	V	
I <sub>VREF+</sub> <sup>(4)</sup>	DAC DC V <sub>REF</sub> current consumption in quiescent mode (Standby mode)	-		-	170	240	μA	With no load, worst code (0x800) at V <sub>REF+</sub> = 3.6 V in terms of DC consumption on the inputs
		-		-	50	75		With no load, worst code (0xF1C) at V <sub>REF+</sub> = 3.6 V in terms of DC consumption on the inputs

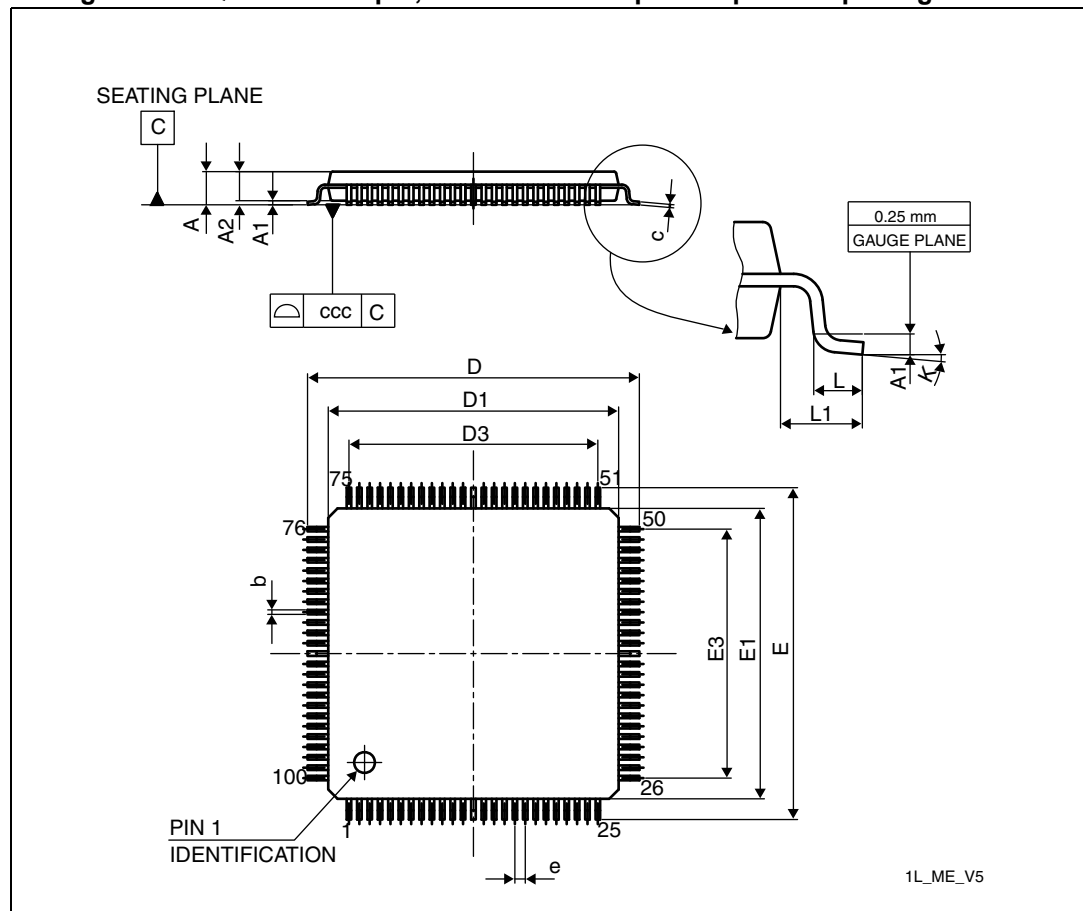


## 7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

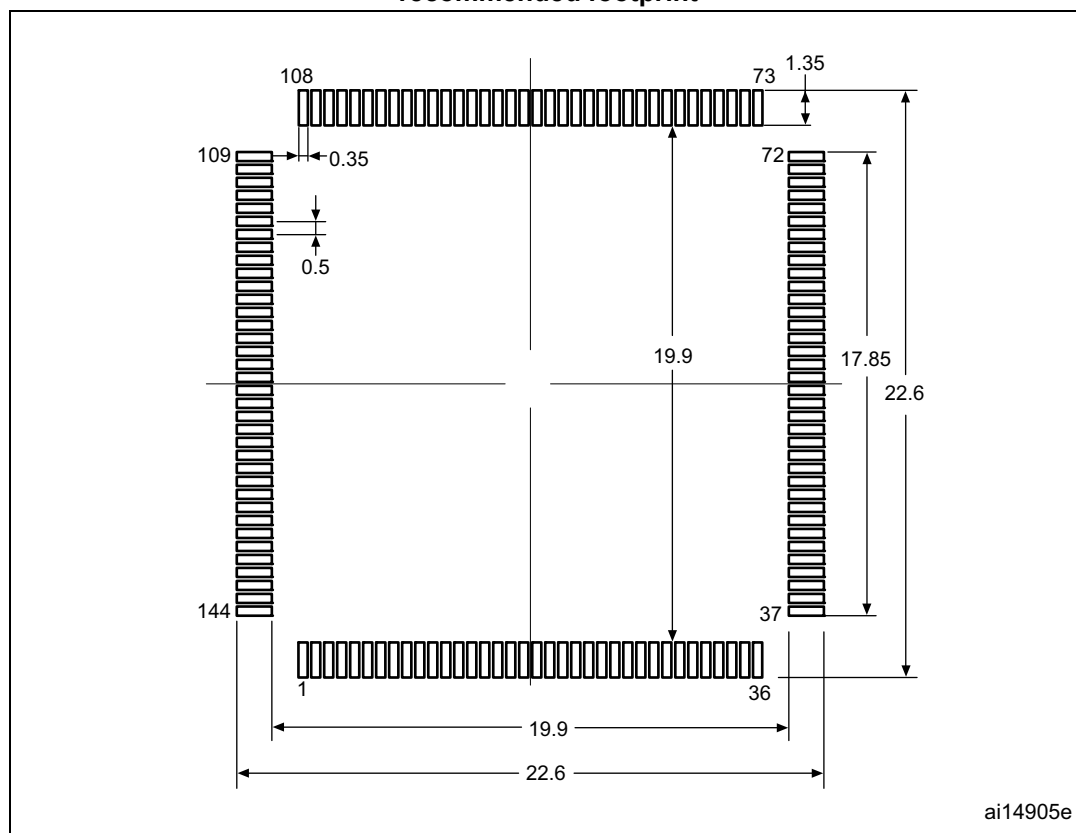
### 7.1 LQFP100 package information

Figure 80. LQFP100 -100-pin, 14 x 14 mm low-profile quad flat package outline



1. Drawing is not to scale.

**Figure 87. LQPF144- 144-pin, 20 x 20 mm low-profile quad flat package recommended footprint**



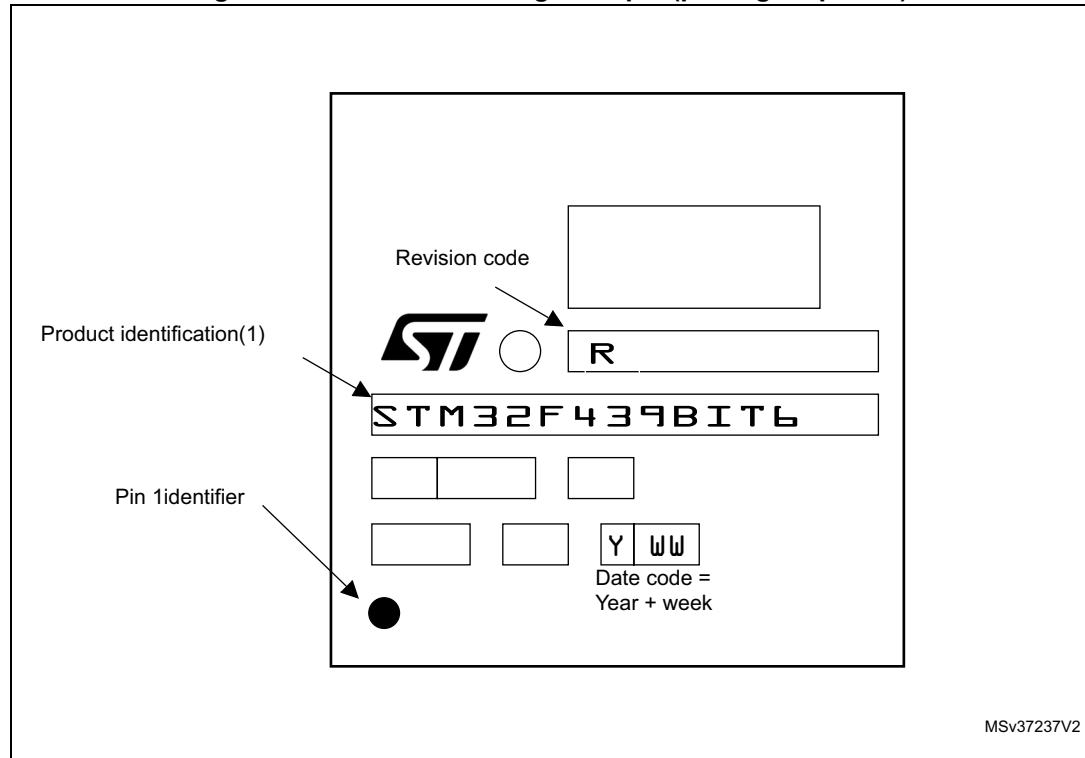
1. Dimensions are expressed in millimeters.

### Device marking for LQFP208

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which depends assembly location, are not indicated below.

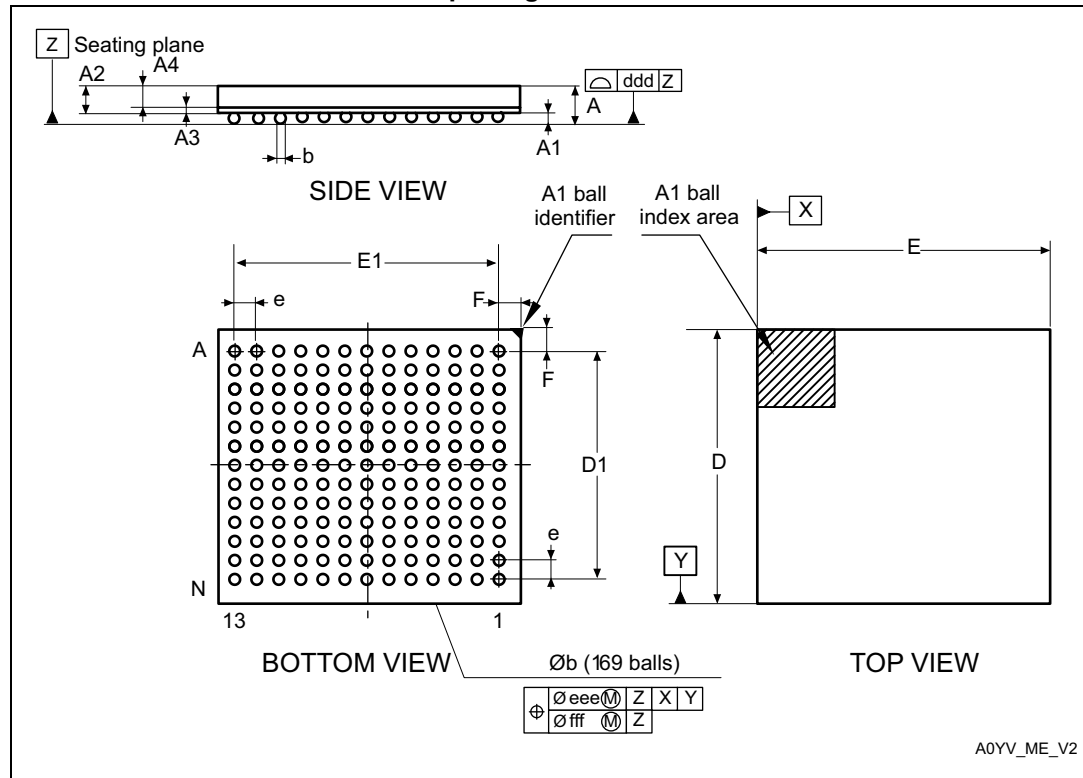
**Figure 94. LQFP208 marking example (package top view)**



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering Samples to run qualification activity.

## 7.6 UFBGA169 package information

**Figure 95. UFBGA169 - 169-ball 7 x 7 mm 0.50 mm pitch, ultra fine pitch ball grid array package outline**



1. Drawing is not to scale.

## 9 Revision history

Table 124. Document revision history

Date	Revision	Changes
12-Aug-2013	1	Initial release.
10-Sep-2013	2	<p>Added STM32F439xx part numbers and related informations.</p> <p><b>STM32F437xx part numbers:</b></p> <p>Replaced FSMC by FMC added Chrom-ART Accelerator and SAI interface.</p> <p>Increased core, timer, GPIOs, SPI maximum frequencies</p> <p>Updated <a href="#">Figure 4: STM32F437xx and STM32F439xx block diagram</a>.</p> <p>Updated <a href="#">Figure 5: STM32F437xx and STM32F439xx Multi-AHB matrix</a>.</p> <p>Removed note in <a href="#">Section : Standby mode</a>.</p> <p>Updated <a href="#">Figure 14: STM32F43x LQFP176 pinout</a>.</p> <p>Updated <a href="#">Table 10: STM32F437xx and STM32F439xx pin and ball definitions</a> and <a href="#">Table 12: STM32F437xx and STM32F439xx alternate function mapping</a>.</p> <p>Modified <a href="#">Figure 19: Memory map</a>.</p> <p>Updated <a href="#">Table 17: General operating conditions</a>, <a href="#">Table 18: Limitations depending on the operating power supply range</a>. Removed note 1 in <a href="#">Table 22: reset and power control block characteristics</a>. Added <a href="#">Table 23: Over-drive switching characteristics</a>.</p> <p>Updated <a href="#">Section : Typical and maximum current consumption</a>, <a href="#">Table 34: Switching output I/O current consumption</a>, <a href="#">Table 35: Peripheral current consumption</a> and <a href="#">Section : On-chip peripheral current consumption</a>.</p> <p>Updated <a href="#">Table 36: Low-power mode wakeup timings</a>.</p> <p>Modified <a href="#">Section : High-speed external user clock generated from an external source</a>, <a href="#">Section : Low-speed external user clock generated from an external source</a>, and <a href="#">Section 6.3.10: Internal clock source characteristics</a>.</p> <p>Updated <a href="#">Table 43: Main PLL characteristics</a> and <a href="#">Table 45: PLL/SAI (audio and LCD-TFT PLL) characteristics</a>.</p> <p>Updated <a href="#">Table 52: EMI characteristics</a>.</p> <p>Updated <a href="#">Table 57: Output voltage characteristics</a> and <a href="#">Table 58: I/O AC characteristics</a>.</p> <p>Updated <a href="#">Table 60: TIMx characteristics</a>, <a href="#">Table 61: I2C characteristics</a>, <a href="#">Table 62: SPI dynamic characteristics</a>, <a href="#">Section : SAI characteristics</a>.</p> <p>Updated <a href="#">Table 102: SDRAM read timings</a> and <a href="#">Table 104: SDRAM write timings</a>.</p>